

550,686

**TITLE: CHIP TESTER HAVING A HEAT-EXCHANGER WITH
AN EXTENDABLE PERIOD OF OPERATION**

RELATED CASES

lec
3/31/05
The present invention is related to another invention¹ having U.S. serial number 10/625,051 which is entitled "METHOD OF EXTENDING THE OPERATIONAL PERIOD OF A HEAT-EXCHANGER IN A CHIP TESTER"

- 5 (Docket 550,685). U.S. patent applications on the present invention and the above identified related invention were co-filed on ^{July 22}~~June~~, 2003, and they have a common Detailed Description.

BACKGROUND OF THE INVENTION:

- 10 The present invention relates to chip testers. More particularly, the present invention relates to chip testers which have a heat-exchanger that include an electric heater and a heatsink that are joined together with a layer of attach material.

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